# **ON Semiconductor**

# Is Now



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# N-Channel Power MOSFET 400 V, 3.4 $\Omega$

#### **Features**

- 100% Avalanche Tested
- Extremely High dv/dt Capability
- Gate Charge Minimized
- Very Low Intrinsic Capacitance
- Improved Diode Reverse Recovery Characteristics
- Zener-protected
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **ABSOLUTE MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	NDD	NDT	Unit
Drain-to-Source Voltage	$V_{DSS}$	400		V
Gate-to-Source Voltage	$V_{GS}$	±3	30	V
Continuous Drain Current Steady State, T <sub>C</sub> = 25°C (Note 1)	Ι <sub>D</sub>	2.1	0.5	Α
Continuous Drain Current Steady State, T <sub>C</sub> = 100°C (Note 1)	Ι <sub>D</sub>	1.3	0.3	Α
Power Dissipation Steady State, T <sub>C</sub> = 25°C	P <sub>D</sub>	37	2.0	W
Pulsed Drain Current	I <sub>DM</sub>	8.0	7.2	Α
Continuous Source Current (Body Diode)	I <sub>S</sub>	2.1	0.5	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>D</sub> = 1 A)	EAS	4	2	mJ
Peak Diode Recovery (Note 2)	dV/dt	12		V/ns
Maximum Temperature for Soldering Leads	TL	26	60	°C
Operating Junction and Storage Temperature	T <sub>J</sub> , T <sub>STG</sub>	–55 to	+150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Limited by maximum junction temperature
- 2.  $I_S \le 2.4 \text{ Å}, \text{ di/dt} \le 400 \text{ A/}\mu\text{s}, V_{DD} \le BV_{DSS}, T_J = +150 ^{\circ}\text{C}$

#### THERMAL RESISTANCE

Parameter	Symbol	Value	Unit	
Junction-to-Case (Drain)	$R_{\theta JC}$	3.4	°C/W	
NDD03N NDT0	tate 3N40Z (Note 4) 40Z–1 (Note 3) 3N40Z (Note 4) 3N40Z (Note 5)	$R_{ hetaJA}$	42 96 62 149	°C/W

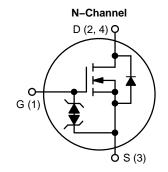
- 3. Insertion mounted
- Surface mounted on FR4 board using 1" sq. pad size (Cu area = 1.127" sq. [2 oz] including traces)
- 5. Surface–mounted on FR4 board using minimum recommended pad size (Cu area = 0.026" sq. [2 oz]).



#### ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX
400 V	3.4 Ω @ 10 V







STYLE 2



IPAK CASE 369D STYLE 2

#### **MARKING & ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 3 of this data sheet.

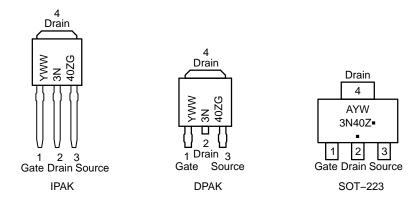
#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		•				
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 i	mA	400			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	Reference to 25°C, I <sub>D</sub> = 1 mA			450		mV/°C
Drain-to-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V	T <sub>J</sub> = 25°C			1	μΑ
			T <sub>J</sub> = 125°C			50	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = \pm 20 \text{ V}$	•			±10	μА
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{DS} = V_{GS}$ , $I_D = 50$	μΑ	3.0	3.9	4.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	Reference to 25°C, I <sub>D</sub>	= 50 μΑ		9.8		mV/°C
Static Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}, I_D = 0.$	6 A		3.0	3.4	Ω
Forward Transconductance	9FS	$V_{DS} = 15 \text{ V}, I_{D} = 0.$	6 A		1.2		S
DYNAMIC CHARACTERISTICS							
Input Capacitance (Note 7)	C <sub>iss</sub>				140		pF
Output Capacitance (Note 7)	C <sub>oss</sub>	Vpo = 50 \/ \/ = 0 \/ f	_ 1 M⊔-		17		1
Reverse Transfer Capacitance (Note 7)	C <sub>rss</sub>	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$			3.0		
Effective output capacitance, energy related (Note 9)	C <sub>o(er)</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0 to 320 V			10		
Effective output capacitance, time related (Note 10)	$C_{o(tr)}$	$I_D$ = constant, $V_{GS}$ = 0 V, $V_{DS}$ = 0 to 320 V			20		
Total Gate Charge (Note 7)	Qg				6.6		nC
Gate-to-Source Charge (Note 7)	Q <sub>gs</sub>				1.7		
Gate-to-Drain ("Miller") Charge (Note 7)	Q <sub>gd</sub>	$V_{DS} = 200 \text{ V}, I_D = 2.4 \text{ A}, V_{DS}$	' <sub>GS</sub> = 10 V		3.5		
Plateau Voltage	V <sub>GP</sub>				6.9		V
Gate Resistance	$R_g$				9.0		Ω
RESISTIVE SWITCHING CHARACTER	ISTICS (Note 8)	)					
Turn-on Delay Time	t <sub>d(on)</sub>				10		ns
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 200 V, I <sub>D</sub> = 2	.4 A,		7.0		
Turn-off Delay Time	t <sub>d(off)</sub>	$V_{GS} = 10 \text{ V}, R_G = 0$	Ω		13		1
Fall Time	t <sub>f</sub>	1			5.0		1
SOURCE-DRAIN DIODE CHARACTER	RISTICS		•				
Diode Forward Voltage	e $V_{SD}$ $T_{J} = 25^{\circ}C$		$T_J = 25^{\circ}C$		0.8	1.5	V
		$I_S = 0.5 \text{ A}, V_{GS} = 0 \text{ V}$ $T_J = 100^{\circ}\text{C}$			0.7		1
Reverse Recovery Time	t <sub>rr</sub>	$V_{GS} = 0 \text{ V, } V_{DD} = 30 \text{ V, } I_{S} = 2.4 \text{ A,}$ $d_i/d_t = 100 \text{ A/}\mu\text{s}$			152		ns
Charge Time	t <sub>a</sub>				62		1
Discharge Time	t <sub>b</sub>				90		1
Reverse Recovery Charge	Q <sub>rr</sub>				452		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 6. Pulse Width  $\leq$  380  $\mu$ s, Duty Cycle  $\leq$  2%. 7. Guaranteed by design.

- Suitchined by design.
   Switching characteristics are independent of operating junction temperatures.
   C<sub>o(er)</sub> is a fixed capacitance that gives the same stored energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>(BR)DSS</sub>
   C<sub>o(tr)</sub> is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>(BR)DSS</sub>

#### **MARKING DIAGRAMS**



A = Assembly Location

= Year

W, WW = Work Week

3N40Z = Specific Device Code G or ■ = Pb–Free Package

(\*Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NDD03N40Z-1G	IPAK (Pb-Free, Halogen Free)	75 Units / Rail
NDD03N40ZT4G	DPAK (Pb-Free, Halogen Free)	2500 / Tape & Reel
NDT03N40ZT1G	SOT-223 (Pb-Free, Halogen Free)	1000 / Tape & Reel
NDT03N40ZT3G	SOT-223 (Pb-Free, Halogen Free)	4000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **TYPICAL CHARACTERISTICS**

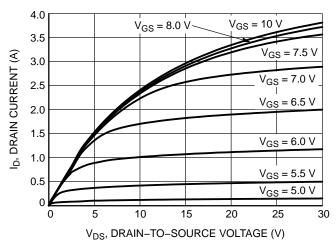


Figure 1. On-Region Characteristics

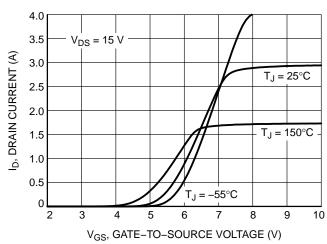


Figure 2. Transfer Characteristics

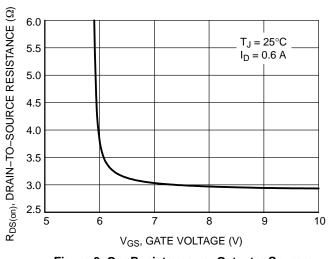


Figure 3. On-Resistance vs. Gate-to-Source Voltage

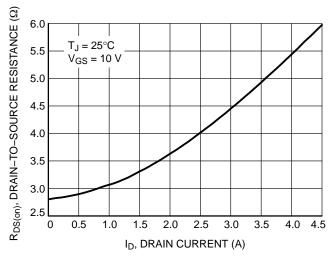


Figure 4. On–Resistance vs. Drain Current and

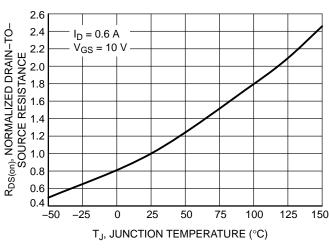


Figure 5. On–Resistance Variation with Temperature

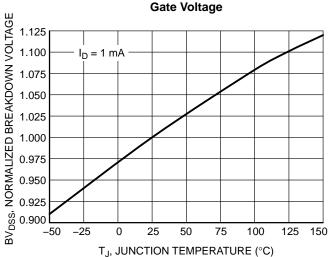


Figure 6. Breakdown Voltage Variation with Temperature

#### **TYPICAL CHARACTERISTICS**

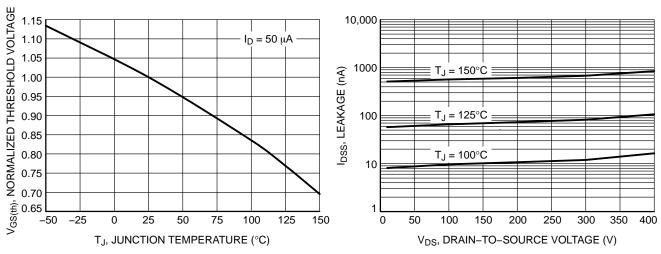


Figure 7. Threshold Voltage Variation with Temperature

Figure 8. Drain-to-Source Leakage Current vs. Voltage

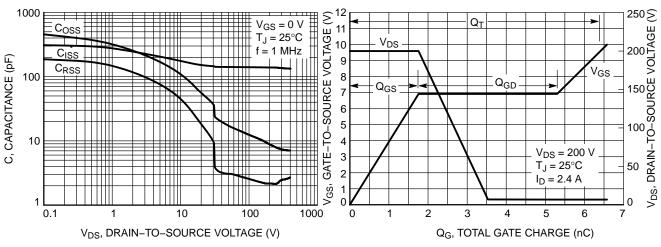


Figure 9. Capacitance Variation

Figure 10. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

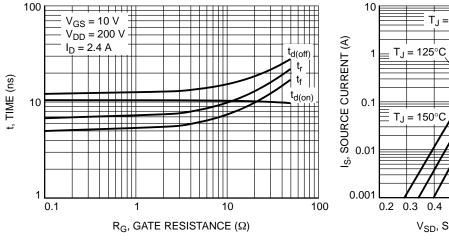


Figure 11. Resistive Switching Time Variation vs. Gate Resistance

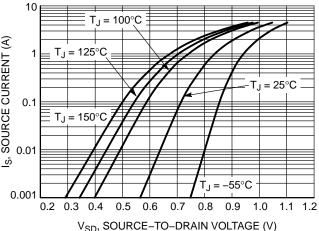


Figure 12. Diode Forward Voltage vs. Current

#### **TYPICAL CHARACTERISTICS**

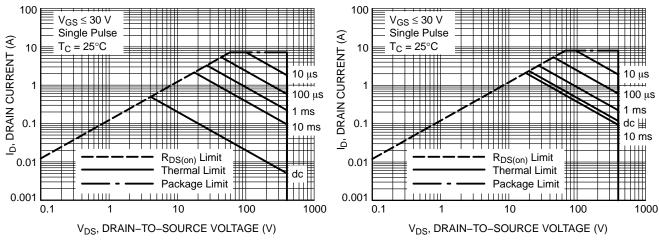


Figure 13. Maximum Rated Forward Biased Safe Operating Area for NDT03N40Z

Figure 14. Maximum Rated Forward Biased Safe Operating Area for NDD03N40Z

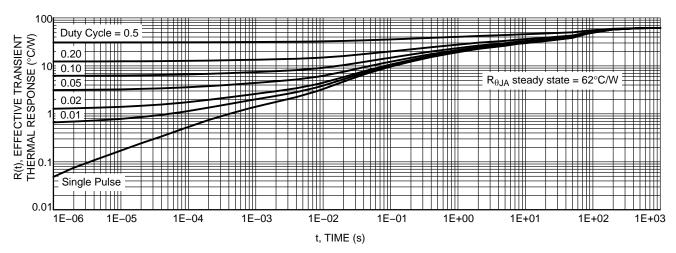


Figure 15. Thermal Impedance (Junction-to-Ambient) for NDT03N40Z

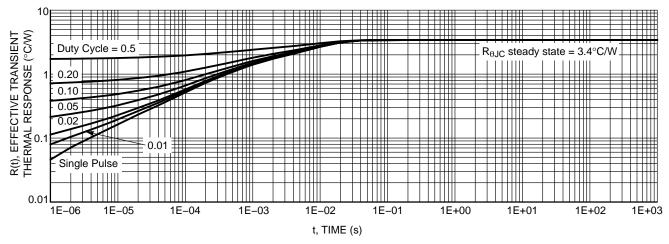
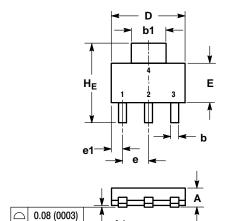
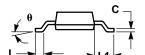


Figure 16. Thermal Impedance (Junction-to-Case) for NDD03N40Z

#### **PACKAGE DIMENSIONS**

SOT-223 (TO-261) CASE 318E-04 ISSUE N



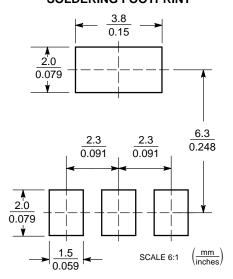


- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: INCH.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.50	1.63	1.75	0.060	0.064	0.068
A1	0.02	0.06	0.10	0.001	0.002	0.004
b	0.60	0.75	0.89	0.024	0.030	0.035
b1	2.90	3.06	3.20	0.115	0.121	0.126
С	0.24	0.29	0.35	0.009	0.012	0.014
D	6.30	6.50	6.70	0.249	0.256	0.263
E	3.30	3.50	3.70	0.130	0.138	0.145
е	2.20	2.30	2.40	0.087	0.091	0.094
e1	0.85	0.94	1.05	0.033	0.037	0.041
L	0.20			0.008		
L1	1.50	1.75	2.00	0.060	0.069	0.078
HE	6.70	7.00	7.30	0.264	0.276	0.287
θ	0°	_	10°	0°	_	10°

STYLE 3: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

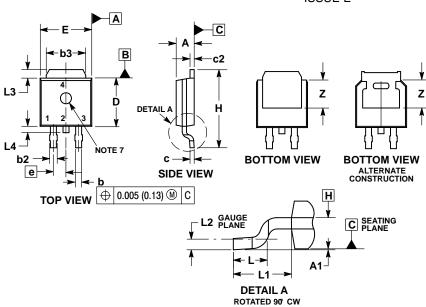
#### **SOLDERING FOOTPRINT**



#### PACKAGE DIMENSIONS

# **DPAK (SINGLE GAUGE)**

CASE 369C **ISSUE E** 



NOTES:

- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

  2. CONTROLLING DIMENSION: INCHES.

  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.

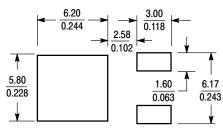
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

  5. DIMENSIONS D AND F ARP DETERMINED AT THE
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PI ANF H
- 7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114	REF	2.90	REF
L2	0.020	BSC	0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

#### **SOLDERING FOOTPRINT\***

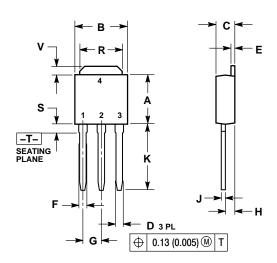


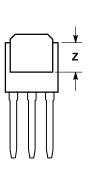
 $\left(\frac{\text{mm}}{\text{inches}}\right)$ SCALE 3:1

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

#### **IPAK** CASE 369D **ISSUE C**





#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETER		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
E	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	BSC	2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

STYLE 2:

- PIN 1. GATE 2. DRAIN

  - SOURCE 3. DRAIN

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